

AOT2144L/AOB2144L

40V N-Channel MOSFET

General Description

- Trench Power MV MOSFET technology
- Low R_{DS(ON)}
- Low Gate Charge
- Opitimized Ruggedness
- RoHS and Halogen-Free Compliant

Product Summary

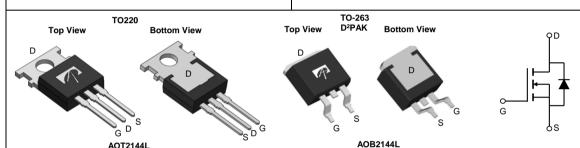
 $\begin{array}{lll} V_{DS} & 40V \\ I_{D} \; (at \; V_{GS} \! = \! 10V) & 120 \; A \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 10V) & < 2.3 m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 4.5V) & < 4 m\Omega \end{array}$

100% UIS Tested 100% Rg Tested



Applications

- DC Motor Driver
- Synchronous Rectification in DC/DC and AC/DC Converters



Orderable Part Number	Package Type	Form	Minimum Order Quantity
AOT2144L	TO-220	Tube	1000
AOB2144L	TO-263	Tape & Reel	800

Absolute Maximum Ratings T_A=25°C unless otherwise noted Parameter Symbol Maximum Units Drain-Source Voltage V_{DS} 40 ٧ Gate-Source Voltage ±20 ٧ V_{GS} T_C=25°C 120 ^G Continuous Drain T_C=25°C 205 ¹ I_D Current^G Α T_C=100°C 120 ^G Pulsed Drain Current 772 I_{DM} T_A=25°C 44 Continuous Drain Α I_{DSM} T_A=70°C 35 Current Avalanche Current C 47 Α I_{AS} Avalanche energy 331 L=0.3mH E_AS mJ T_C=25°C 187 P_D W Power Dissipation B T_C=100°C 93 T_A=25°C 8.3 W PDSM T_A=70°C Power Dissipation A 5.3 Junction and Storage Temperature Range T_J, T_{STG} -55 to 175 °C

Thermal Characteristics								
Parameter		Symbol	Тур	Max	Units			
	t ≤ 10s	- R _{θJA}	12	15	°C/W			
Maximum Junction-to-Ambient AD	Steady-State		50	60	°C/W			
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	0.6	0.8	°C/W			



Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units				
STATIC PARAMETERS										
BV _{DSS}	Drain-Source Breakdown Voltage	ID=250µA, VGS=0V	40			V				
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =40V, V _{GS} =0V			1	μA				
	Zero Gate Voltage Drain Gurrent	T _J =55°C			5					
I_{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} =±20V			±100	nA				
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_D=250\mu A$	1.4	1.9	2.4	V				
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =20A		1.85	2.3	mΩ				
		T _J =125°C		2.5	3.1	11152				
		V_{GS} =4.5V, I_D =20A		2.45	4	mΩ				
g _{FS}	Forward Transconductance	V_{DS} =5V, I_D =20A		100		S				
V_{SD}	Diode Forward Voltage	I _S =1A, V _{GS} =0V		0.7	1	V				
Is	Maximum Body-Diode Continuous Current ^G				120	Α				
DYNAMIC	PARAMETERS									
C _{iss}	Input Capacitance			5225		pF				
Coss	Output Capacitance	V _{GS} =0V, V _{DS} =20V, f=1MHz		895		pF				
C _{rss}	Reverse Transfer Capacitance			55		pF				
R_g	Gate resistance	f=1MHz	1	2	3.1	Ω				
SWITCHI	NG PARAMETERS									
Q _g (10V)	Total Gate Charge			68	95	nC				
Q _g (4.5V)	Total Gate Charge	V _{GS} =10V, V _{DS} =20V, I _D =20A		28	40	nC				
Q_{gs}	Gate Source Charge	V _{GS} =10V, V _{DS} =20V, I _D =20A		16.5		nC				
Q_{gd}	Gate Drain Charge			4.5		nC				
Q _{oss}	Output Charge	V _{GS} =0V, V _{DS} =20V		37		nC				
t _{D(on)}	Turn-On DelayTime			12.5		ns				
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =20V, R_L =1 Ω ,		9.5		ns				
$t_{D(off)}$	Turn-Off DelayTime	$R_{GEN}=3\Omega$		57.5		ns				
t _f	Turn-Off Fall Time	<u>] </u>		10.5		ns				
t _{rr}	Body Diode Reverse Recovery Time	I _F =20A, di/dt=500A/μs		20		ns				
Q_{rr}	Body Diode Reverse Recovery Charge	I _F =20A, di/dt=500A/μs		60		nC				

A. The value of R_{BJA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_{A} =25° C. The Power dissipation P_{DSM} is based on R _{⊕JA} t≤ 10s and the maximum allowed junction temperature of 150 °C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175° C may be used if the PCB allows it.

- C. Single pulse width limited by junction temperature $T_{J(MAX)}$ =175 $^{\circ}$ C.
- D. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to case $R_{\theta JC}$ and case to ambient.
- E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.

 F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=175° C. The SOA curve provides a single pulse rating.

 G. The maximum current rating is package limited.
- H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C.
- I. The maximum current rating is silicon limited

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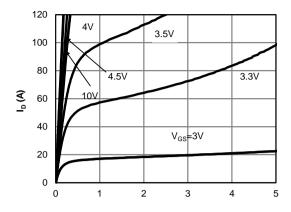
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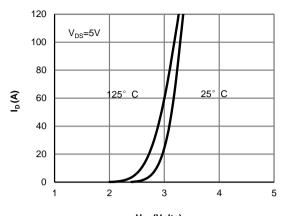
B. The power dissipation P_D is based on $T_{J(MAX)}=175^{\circ}$ C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.



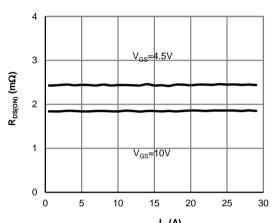
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



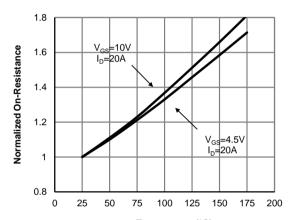
 $V_{\rm DS}$ (Volts) Figure 1: On-Region Characteristics (Note E)



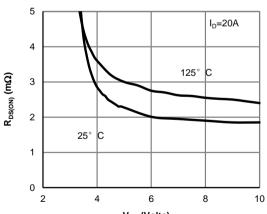
V_{GS} (Volts) Figure 2: Transfer Characteristics (Note E)



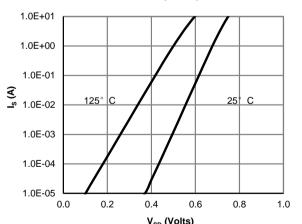
I_D (A)
Figure 3: On-Resistance vs. Drain Current and Gate
Voltage (Note E)



Temperature (°C)
Figure 4: On-Resistance vs. Junction Temperature
(Note E)



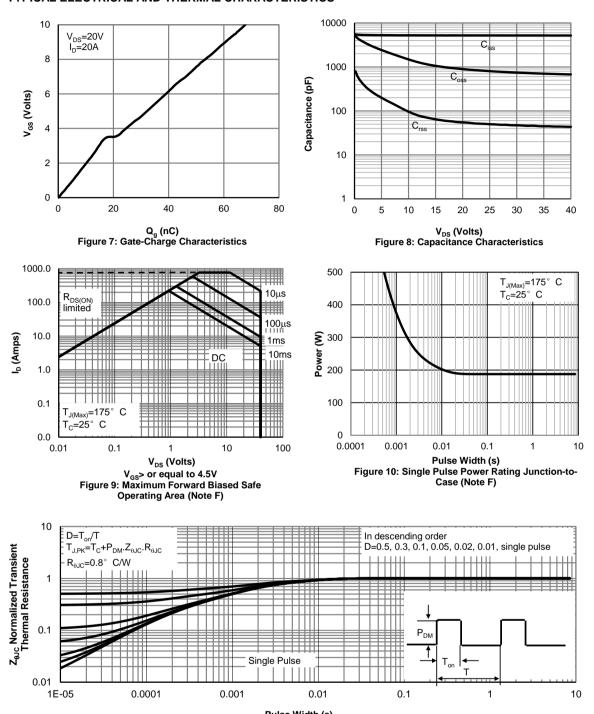
V_{GS} (Volts)
Figure 5: On-Resistance vs. Gate-Source Voltage
(Note E)



V_{SD} (Volts) Figure 6: Body-Diode Characteristics (Note E)



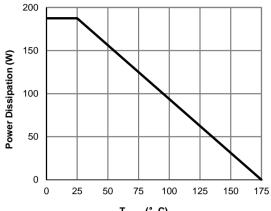
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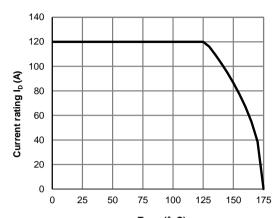
Pulse Width (s)
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)



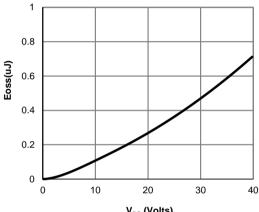
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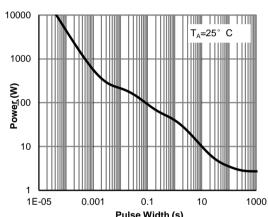
T_{CASE} (° C)
Figure 12: Power De-rating (Note F)



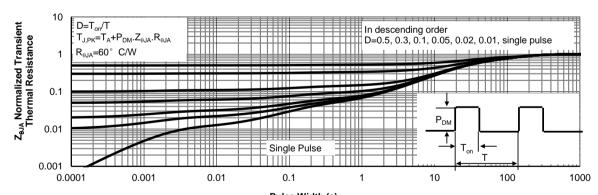
T_{CASE} (° C)
Figure 13: Current De-rating (Note F)



V_{DS} (Volts) Figure 14: Coss stored Energy



Pulse Width (s)
Figure 15: Single Pulse Power Rating
Junction-to-Ambient (Note H)



Pulse Width (s)
Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)



Figure A: Gate Charge Test Circuit & Waveforms

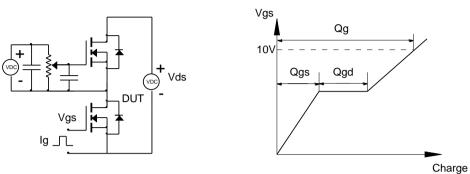


Figure B: Resistive Switching Test Circuit & Waveforms

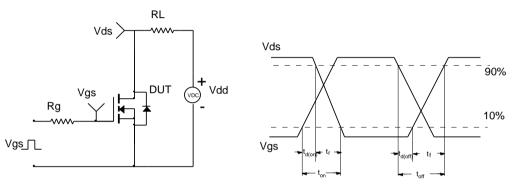


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

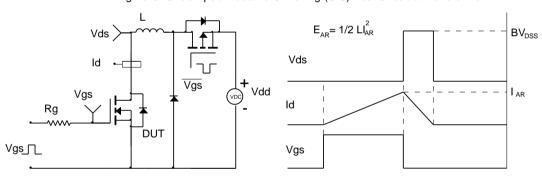
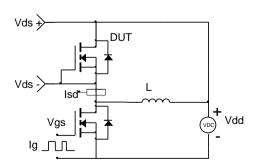
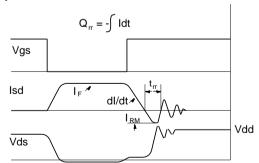


Figure D: Diode Recovery Test Circuit & Waveforms





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